

Notice of References Cited	Application/Control No. 10/627,713	Applicant(s)/Patent Under Reexamination FUJISAWA ET AL.	
	Examiner Hien N Nguyen	Art Unit 2824	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,369,619	11-1994	Ohba, Atsushi	365/230.03
*	B	US-5,838,627	11-1998	Tomishima et al.	365/230.03
*	C	US-6,310,815	10-2001	Yamagata et al.	365/230.03
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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